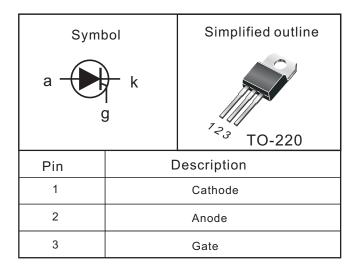
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Description

Glass passivated, sensitive gate thyristors in a plastic envelope, intended for use in general purpose switching and phase control applications. These devices are intended to be interfaced directly to microcontrollers, logic integrated circuits and other low power gate trigger circuits.



Applications:

- ♦ Motor control
- ♦ Industrial and domestic lighting
- ♦ Heating
- ♦ Static switching

Features

- ♦ Blocking voltage to 600 V
- ♦ On-state RMS current to 12A
- ♦ Ultra low gate trigger current

SYMBOL	PARAMETER	Value	Unit
VDRM	Repetitive peak off-state voltages	600	V
It (RMS) RMS on-state current		12	А
ITSM Non-repetitive surge peak on-state current		140	А

SYMBOL	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNIT
Rth(j-c)	Junction to case(DC)		-	1.3	-	°C/W
Rth(j-a)	Junction to ambient		-	60	-	°C/W

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Limiting values in accordance with the Maximum system(IEC 134)

SYMBOL	PARAMETER	CONDITIONS			MIN	Value	UNIT
V_{DRM}/V_{RRM}					-	600	V
I _{T(RMS)}	RMS on-state current	180°C conduction an	gle Tc=1	05℃	-	12	А
I _{TSM}	Non repetitive surge peak on-statecurrent		Tj=25°C	tp=8.3ms	_	- 146	Α
	peak on-statecurrent		Tj=25°C	tp=10ms	-	140	Α
IT _(AV)	Average on-state current	180°C conduction angle Tc=105°C			-	-	А
l²t	I²t Value for fusing	T _p =10ms		Tj=25℃	-	98	A ² S
DI/dt	Critical rate of rise of on-state current	IG=2x I _{GT} ,tr<=100ns	F=60H _z	Tj=125℃	-	50	A/ μs
I _{GM}	Peak gate current		tp=20us	Tj=125℃	-	4	А
I _{DRM}	V _{DRM} =V _{RRM}			Tj=25℃	-	5	μА
I _{RRM}	V _{DRM} =V _{RRM}			Tj=125℃	-	2	mA
P _{G(AV)}	Average gate power dissipation			Tj=125℃	-	1	W
T _{stg}	Storage junction temperature range				-40	150	$^{\circ}$
T _j	Operating junction Temperature range				-40	125	$^{\circ}$

T_J=25°C unless otherwise stated

SYMBOL	PARAMETER	CONDITIONS		TYP	MAX	UNIT		
Static characteristics								
I _{GT} V _{GT}		V _D =12V; RL=33 Ω	0.5	-	5 1.3	mA V		
I _L		I _G =1.2I _{GT}	-	-	30	mA		
I _H		I _⊤ =500mA Gate open	-	-	15	mA		
V_{GD}		$V_D = V_{DRM} R_L = 3.3 K \Omega Tj = 125 ^{\circ}C$	0.2	-	-	V		
dV/dt		V _D =67%V _{DRM} Gateopen;T _J =125°C	40	-	-	V/us		

Dynamic Characteristics

V _{TM}	I _{TM} =24A tp=380 μ s	T _J =25℃	-	-	1.6	V
V _{to}	Threshold voltage Dynamic resistance	T _J =125℃ T _J =125℃	-	-	0.85 30	V m Ω

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Description

Fig. 1: Maximum average power dissipation versus average on-state current.

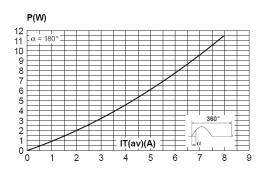


Fig. 2-1: Average and D.C. on-state current versus case temperature.

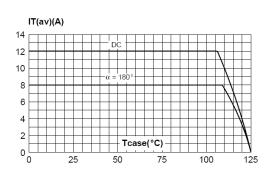


Fig. 2-2: Average and D.C. on-state current versus ambient temperature (device mounted on FR4 with recommended pad layout) (DPAK and D²PAK).

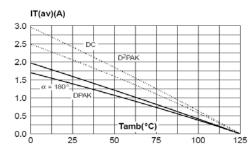


Fig. 3-1: Relative variation of thermal impedance junction to case versus pulse duration.

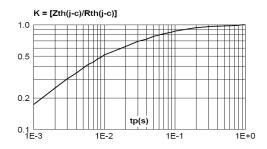


Fig. 3-2: Relative variation of thermal impedance junction to ambient versus pulse duration (recommended pad layout, FR4 PC board).

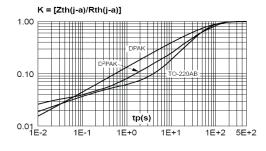
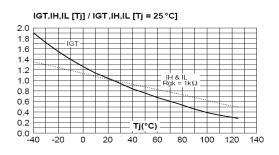


Fig. 4-1: Relative variation of gate trigger current, holding current and latching versus junction temperature for TS12 series.



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Fig. 4-2: Relative variation of gate trigger current, holding current and latching current versus junction temperature for TN12 & TYN series.

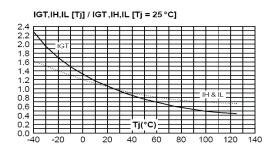


Fig. 5: Relative variation of holding current versus gate-cathode resistance (typical values) for TS12 series.

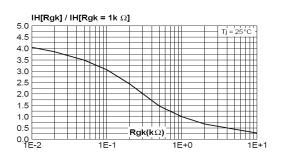


Fig. 6: Relative variation of dV/dt immunity versus gate-cathode resistance (typical values) for TS12 series.

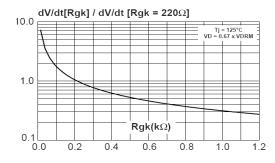


Fig. 7: Relative variation of dV/dt immunity versus gate-cathode capacitance (typical values) for TS12 series.

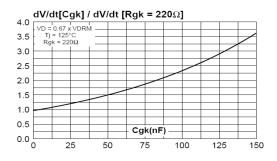


Fig. 8: Surge peak on-state current versus number of cycles (TS12/TN12/TYN).

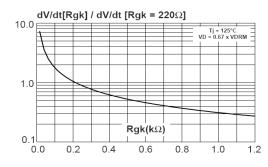
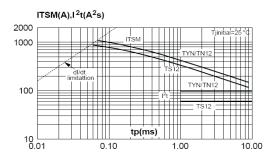


Fig. 9: Non-repetitive surge peak on-state current for a sinusoidal pulse with width tp < 10 ms, and corresponding values of I²t.





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Fig. 10: On-state characteristics (maximum values).

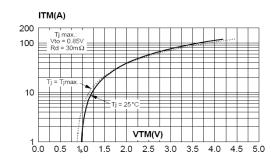
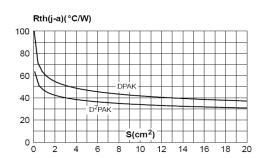


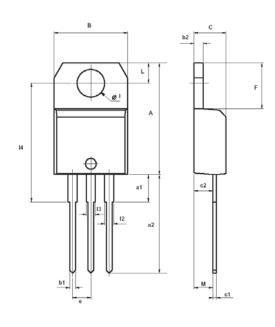
Fig. 11: Thermal resistance junction to ambient versus copper surface under tab (Epoxy printed circuit board FR4, copper thickness: $35\,\mu m$).



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MECHANICAL DATA

Dimensions in mm Net Mass: 2 g TO-220AB



	DIMENSIONS					
REF.	Millimeters			Inches		
	Min.	Тур.	Max.	Min.	Тур.	Max.
Α	15.20		15.90	0.598		0.625
a1		3.75			0.147	
a2	13.00		14.00	0.511		0.551
В	10.00		10.40	0.393		0.409
b1	0.61		0.88	0.024		0.034
b2	1.23		1.32	0.048		0.051
С	4.40		4.60	0.173		0.181
c1	0.49		0.70	0.019		0.027
c2	2.40		2.72	0.094		0.107
е	2.40		2.70	0.094		0.106
F	6.20		6.60	0.244		0.259
- 1	3.75		3.85	0.147		0.151
14	15.80	16.40	16.80	0.622	0.646	0.661
L	2.65		2.95	0.104		0.116
12	1.14		1.70	0.044		0.066
13	1.14		1.70	0.044		0.066
М		2.60			0.102	